Application/Control No.	Applicant(s)/Patent under Reexamination	
10/037,329	ISHII, MIRUKA	
Examiner	Art Unit	
James D. Ewart	2617	

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Class	Subclass	Date	Examiner
455	405 406 407 408 409 414.1 414.2	1/18/2007	JDE
	458 567		
379	114.1		
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	114,17		
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•	121.02		
	373.01 -		
	373.04		
	374.01		
	374.02		
705	14		

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